

74LCXZ16244

Low Voltage 16-Bit Buffer/Line Driver with 5V Tolerant Inputs and Outputs

General Description

The LCXZ16244 contains sixteen non-inverting buffers with 3-STATE outputs designed to be employed as a memory and address driver, clock driver, or bus oriented transmitter/receiver. The device is nibble controlled. Each nibble has separate 3-STATE control inputs which can be shorted together for full 16-bit operation.

When V_{CC} is between 0 and 1.5V, the LCXZ16244 is in the high impedance state during power up or power down. This places the outputs in high impedance (Z) state preventing intermittent low impedance loading or glitching in bus oriented applications.

The LCXZ16244 is designed for low voltage (2.7V or 3.3V) V_{CC} applications with capability of interfacing to a 5V signal environment.

The LCXZ16244 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

Features

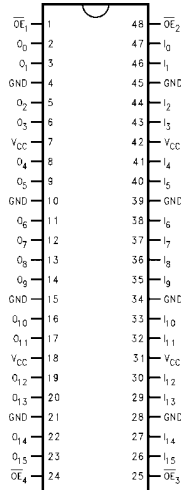
- 5V tolerant inputs and outputs
- Guaranteed power up/down high impedance
- Supports live insertion/withdrawal
- 2.7V–3.6V V_{CC} specifications provided
- 4.5 ns t_{PD} max ($V_{CC} = 3.0V$), 20 μA I_{CC} max
- ± 24 mA output drive ($V_{CC} = 3.0V$)
- Implements patented noise/EMI reduction circuitry
- Latch-up performance exceeds 500 mA
- ESD performance:
 - Human body model > 2000V
 - Machine model > 200V

Ordering Code:

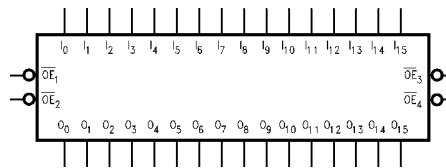
| Order Number | Package Number | Package Description |
|----------------|----------------|---|
| 74LCXZ16244MEA | MS48A | 48-Lead Small Shrink Outline Package (SSOP), JEDEC MO-118, 0.300 Wide |
| 74LCXZ16244MTD | MTD48 | 48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Logic Symbol



Pin Descriptions

| Pin Names | Description |
|-------------------|----------------------------------|
| \overline{OE}_n | Output Enable Input (Active LOW) |
| I_0 – I_{15} | Inputs |
| O_0 – O_{15} | Outputs |

Truth Tables

| Inputs | | Outputs |
|-------------------|--------------------------------|--------------------------------|
| \overline{OE}_1 | I ₀ -I ₃ | O ₀ -O ₃ |
| L | L | L |
| L | H | H |
| H | X | Z |

| Inputs | | Outputs |
|-------------------|---------------------------------|---------------------------------|
| \overline{OE}_3 | I ₈ -I ₁₁ | O ₈ -O ₁₁ |
| L | L | L |
| L | H | H |
| H | X | Z |

| Inputs | | Outputs |
|-------------------|--------------------------------|--------------------------------|
| \overline{OE}_2 | I ₄ -I ₇ | O ₄ -O ₇ |
| L | L | L |
| L | H | H |
| H | X | Z |

| Inputs | | Outputs |
|-------------------|----------------------------------|----------------------------------|
| \overline{OE}_4 | I ₁₂ -I ₁₅ | O ₁₂ -O ₁₅ |
| L | L | L |
| L | H | H |
| H | X | Z |

H = HIGH Voltage Level
L = LOW Voltage Level

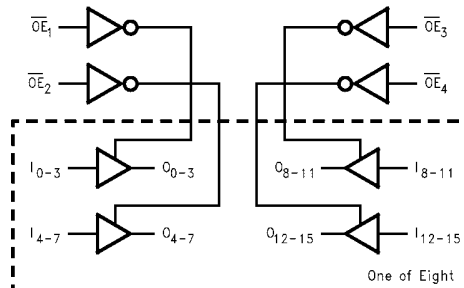
X = Immaterial
Z = High Impedance

Functional Description

The LCXZ16244 contains sixteen non-inverting buffers with 3-STATE standard outputs. The device is nibble (4 bits) controlled with each nibble functioning identically, but independent of the other. The control pins can be shorted together to obtain full 16-bit operation. The

3-STATE outputs are controlled by an Output Enable (\overline{OE}_n) input for each nibble. When \overline{OE}_n is LOW, the outputs are in 2-state mode. When \overline{OE}_n is HIGH, the outputs are in the high impedance mode, but this does not interfere with entering new data into the inputs.

Logic Diagram



| Absolute Maximum Ratings (Note 1) | | | | | |
|-----------------------------------|----------------------------------|--|--|-------|--|
| Symbol | Parameter | Value | Conditions | Units | |
| V_{CC} | Supply Voltage | -0.5 to +7.0 | | V | |
| V_I | DC Input Voltage | -0.5 to +7.0 | | V | |
| V_O | DC Output Voltage | -0.5 to +7.0 -0.5 to $V_{CC} + 0.5$ | Output in 3-STATE or $V_{CC} = 0-1.5V$ Output in HIGH or LOW State (Note 2) | V | |
| I_{IK} | DC Input Diode Current | -50 | $V_I < GND$ | mA | |
| I_{OK} | DC Output Diode Current | -50 +50 | $V_O < GND$ $V_O > V_{CC}$ | mA | |
| I_O | DC Output Source/Sink Current | ± 50 | | mA | |
| I_{CC} | DC Supply Current per Supply Pin | ± 100 | | mA | |
| I_{GND} | DC Ground Current per Ground Pin | ± 100 | | mA | |
| T_{STG} | Storage Temperature | -65 to +150 | | °C | |

| Recommended Operating Conditions (Note 3) | | | | | |
|---|---|--|-----|----------------------|----|
| Symbol | Parameter | Min | Max | Units | |
| V_{CC} | Supply Voltage | Operating | 2.7 | 3.6 | V |
| V_I | Input Voltage | 0 | 5.5 | V | |
| V_O | Output Voltage | HIGH or LOW State 3-STATE or $V_{CC} = OFF$ | 0 | V_{CC} 5.5 | V |
| I_{OH}/I_{OL} | Output Current | $V_{CC} = 3.0V - 3.6V$ $V_{CC} = 2.7V - 3.0V$ | | ± 24 ± 12 | mA |
| T_A | Free-Air Operating Temperature | -40 | 85 | °C | |
| $\Delta t/\Delta V$ | Input Edge Rate, $V_{IN} = 0.8V-2.0V$, $V_{CC} = 3.0V$ | 0 | 10 | ns/V | |

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: I_O Absolute Maximum Rating must be observed.

Note 3: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

| Symbol | Parameter | Conditions | V_{CC} (V) | $T_A = -40^\circ C$ to $+85^\circ C$ | | Units |
|-----------------|---|--|-----------------|--------------------------------------|-----------|---------|
| | | | | Min | Max | |
| V_{IH} | HIGH Level Input Voltage | | 2.7 - 3.6 | 2.0 | | V |
| V_{IL} | LOW Level Input Voltage | | 2.7 - 3.6 | | 0.8 | V |
| V_{OH} | HIGH Level Output Voltage | $I_{OH} = -100 \mu A$ | 2.7 - 3.6 | $V_{CC} - 0.2$ | | V |
| | | $I_{OH} = -12 mA$ | 2.7 | 2.2 | | |
| | | $I_{OH} = -18 mA$ | 3.0 | 2.4 | | |
| | | $I_{OH} = -24 mA$ | 3.0 | 2.2 | | |
| V_{OL} | LOW Level Output Voltage | $I_{OL} = 100 \mu A$ | 2.7 - 3.6 | | 0.2 | V |
| | | $I_{OL} = 12 mA$ | 2.7 | | 0.4 | |
| | | $I_{OL} = 16 mA$ | 3.0 | | 0.4 | |
| | | $I_{OL} = 24 mA$ | 3.0 | | 0.55 | |
| I_I | Input Leakage Current | $0 \leq V_I \leq 5.5V$ | 2.7 - 3.6 | | ± 5.0 | μA |
| I_{OZ} | 3-STATE Output Leakage | $0 \leq V_O \leq 5.5V$ $V_I = V_{IH}$ or V_{IL} | 2.7 - 3.6 | | ± 5.0 | μA |
| I_{OFF} | Power-Off Leakage Current | V_I or $V_O = 5.5V$ | 0 | | 10 | μA |
| $I_{PU/PD}$ | Power Up/Down 3-STATE Output Current | $V_O = 0.5V$ to V_{CC} $V_I = GND$ or V_{CC} | 0 - 1.5 | | ± 5.0 | μA |
| I_{CC} | Quiescent Supply Current | $V_I = V_{CC}$ or GND | 2.7 - 3.6 | | 225 | μA |
| | | $3.6V \leq V_I$, $V_O \leq 5.5V$ (Note 4) | 2.7 - 3.6 | | ± 225 | |
| ΔI_{CC} | Increase in I_{CC} per Input | $V_{IH} = V_{CC} - 0.6V$ | 2.7 - 3.6 | | 500 | μA |

Note 4: Outputs disabled or 3-STATE only.

AC Electrical Characteristics

| Symbol | Parameter | $T_A = -40^\circ\text{C to } +85^\circ\text{C}, R_L = 500 \Omega$ | | | | Units |
|------------|--------------------------------|---|-----|-----------------------|-----|-------|
| | | $V_{CC} = 3.3V \pm 0.3V$ | | $V_{CC} = 2.7V$ | | |
| | | $C_L = 50 \text{ pF}$ | | $C_L = 50 \text{ pF}$ | | |
| | | Min | Max | Min | Max | |
| t_{PHL} | Propagation Delay | 1.0 | 4.5 | 1.0 | 5.2 | ns |
| t_{PLH} | Data to Output | 1.0 | 4.5 | 1.0 | 5.2 | |
| t_{PZL} | Output Enable Time | 1.0 | 5.5 | 1.0 | 6.3 | ns |
| t_{PZH} | | 1.0 | 5.5 | 1.0 | 6.3 | |
| t_{PLZ} | Output Disable Time | 1.0 | 5.4 | 1.0 | 5.7 | ns |
| t_{PHZ} | | 1.0 | 5.4 | 1.0 | 5.7 | |
| t_{OSHL} | Output to Output Skew (Note 5) | | 1.0 | | | ns |
| t_{OSLH} | | | 1.0 | | | |

Note 5: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}). Parameter guaranteed by design.

Dynamic Switching Characteristics

| Symbol | Parameter | Conditions | V_{CC} (V) | $T_A = 25^\circ\text{C}$ | Units |
|-----------|--------------------------------------|---|-----------------|--------------------------|-------|
| | | | | Typical | |
| V_{OLP} | Quiet Output Dynamic Peak V_{OL} | $C_L = 50 \text{ pF}, V_{IH} = 3.3V, V_{IL} = 0V$ | 3.3 | 0.8 | V |
| V_{OLV} | Quiet Output Dynamic Valley V_{OL} | $C_L = 50 \text{ pF}, V_{IH} = 3.3V, V_{IL} = 0V$ | 3.3 | -0.8 | V |

Capacitance

| Symbol | Parameter | Conditions | Typical | Units |
|-----------|-------------------------------|--|---------|-------|
| C_{IN} | Input Capacitance | $V_{CC} = \text{Open}, V_I = 0V \text{ or } V_{CC}$ | 7 | pF |
| C_{OUT} | Output Capacitance | $V_{CC} = 3.3V, V_I = 0V \text{ or } V_{CC}$ | 8 | pF |
| C_{PD} | Power Dissipation Capacitance | $V_{CC} = 3.3V, V_I = 0V \text{ or } V_{CC}, f = 10 \text{ MHz}$ | 20 | pF |

AC LOADING and WAVEFORMS Generic for LCX Family

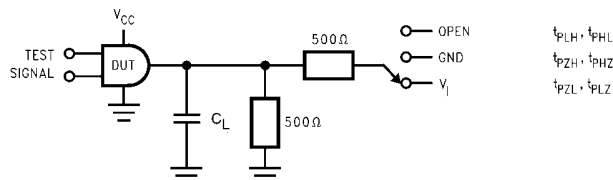
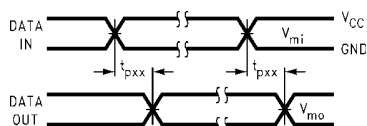
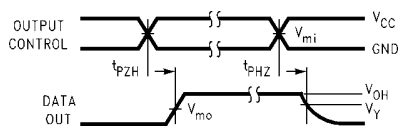


FIGURE 1. AC Test Circuit (C_L includes probe and jig capacitance)

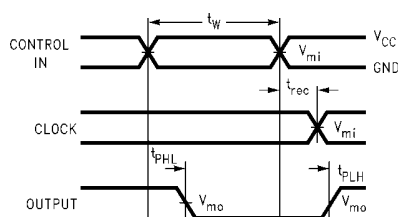
| V_I | C_L |
|----------------------------------|-------|
| 6V for $V_{CC} = 3.3V, 2.7V$ | 50 pF |
| $V_{CC} * 2$ for $V_{CC} = 2.5V$ | 30 pF |



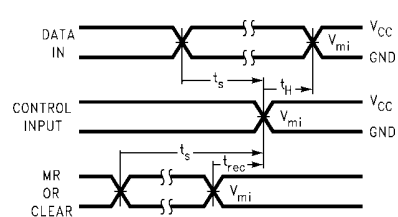
Waveform for Inverting and Non-Inverting Functions



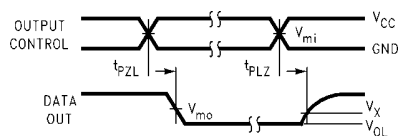
3-STATE Output High Enable and Disable Times for Logic



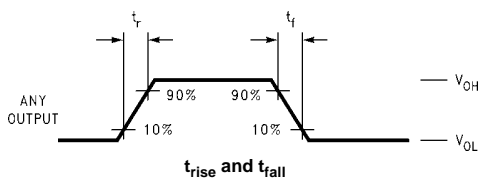
Propagation Delay, Pulse Width and t_{rec} Waveforms



Setup Time, Hold Time and Recovery Time for Logic



3-STATE Output Low Enable and Disable Times for Logic

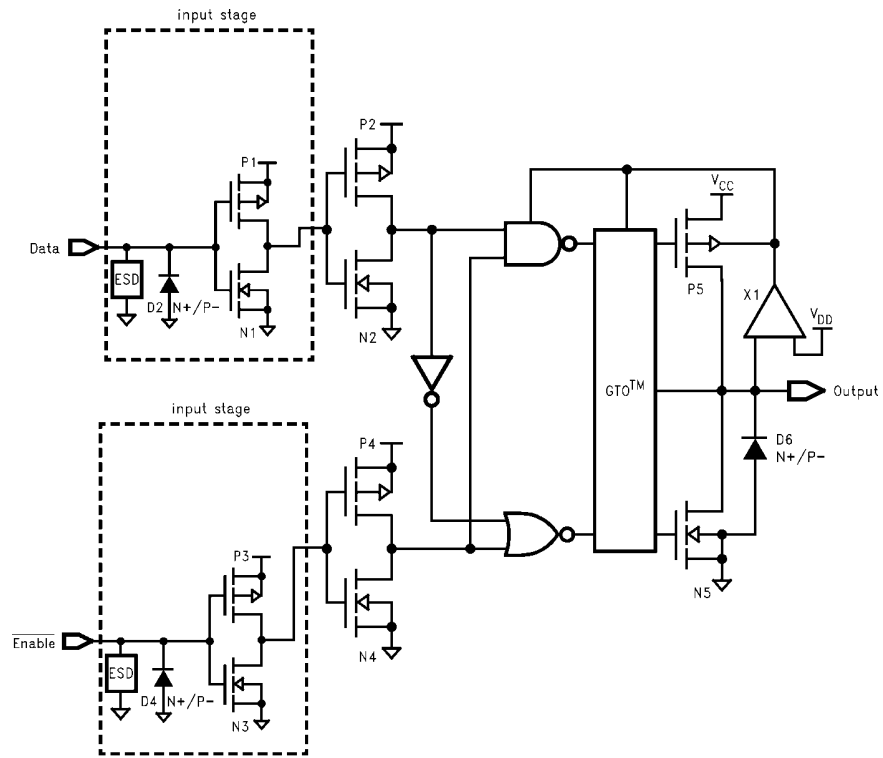


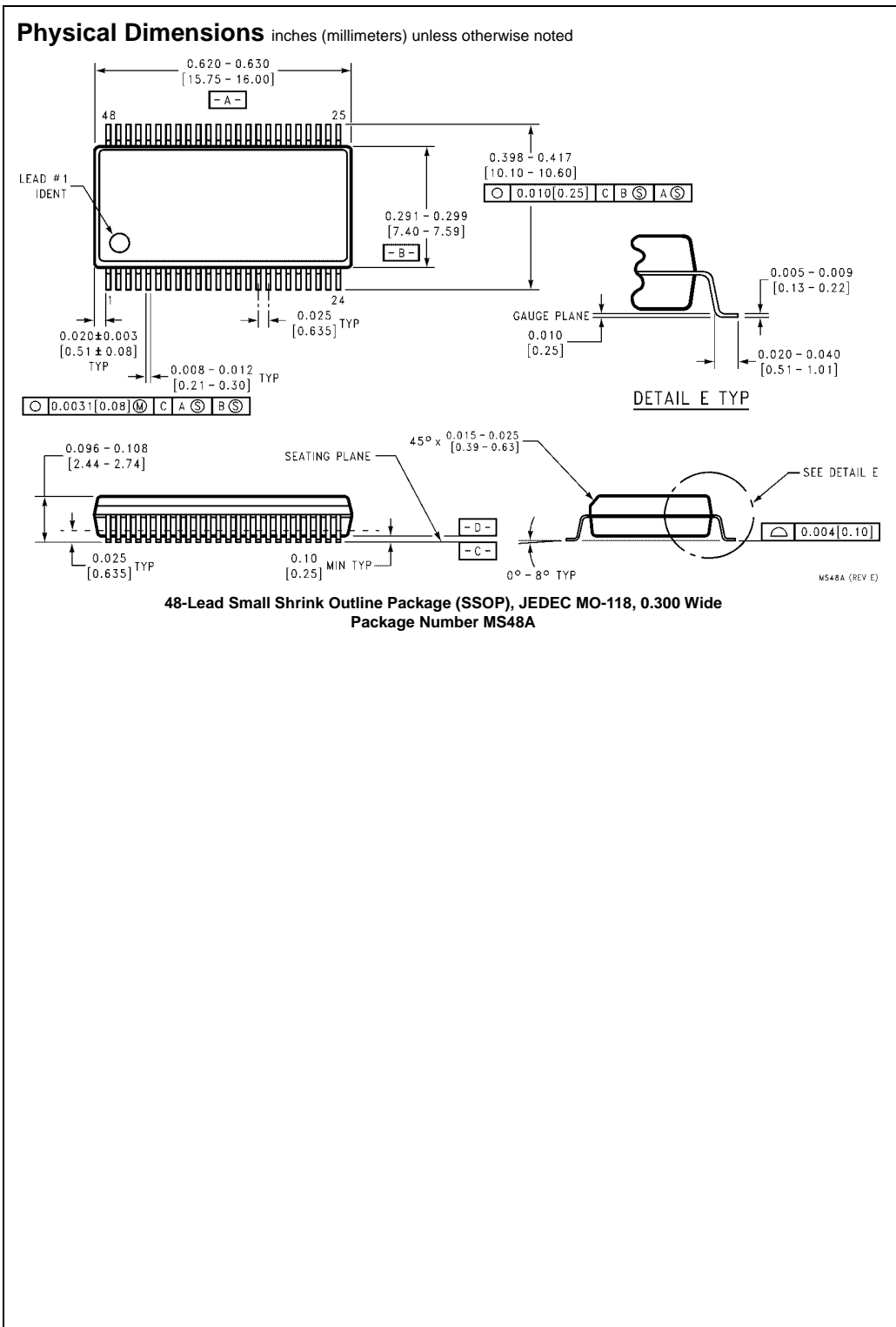
t_{rise} and t_{fall}

FIGURE 2. Waveforms
(Input Characteristics; $f = 1MHz, t_R = t_F = 3ns$)

| Symbol | V_{CC} | |
|----------|-----------------|-----------------|
| | 3.3V ± 0.3V | 2.7V |
| V_{mi} | 1.5V | 1.5V |
| V_{mo} | 1.5V | 1.5V |
| V_x | $V_{OL} + 0.3V$ | $V_{OL} + 0.3V$ |
| V_y | $V_{OH} - 0.3V$ | $V_{OH} - 0.3V$ |

Schematic Diagram Generic for LCX Family





Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

12.50±0.10
-A-

0.40 TYP

48 43 30 25

8.10

4.05

6.10±0.10
-B-

PIN #1 IDENT.

1 6 19 24

0.2 C B A
ALL LEAD TIPS

48 43 30 25

4.60 9.20

2.30

1 6 19 24

0.30

0.50

LAND PATTERN RECOMMENDATION

SEE DETAIL A

0.09-0.20

1.2 MAX

0.1 C
ALL LEAD TIPS

0.90^{+0.15}_{-0.10}

0.50

0.17-0.27

0.10±0.05

0.13 M A B S C S

DIMENSIONS ARE IN MILLIMETERS

NOTES:
A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATE 7/93.
B. DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTD48RevB1

48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide Package Number MTD48

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